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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)			Application Number	10/047,978	
			Filing Date	1/13/02	
			First Named Inventor	Steven Teig	
			Group Art Unit	2825	
			Examiner Name	<i>Let with more</i>	
Sheet	1	of	1	Attorney Docket Number	SPLX.P0089

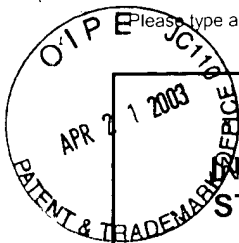
U.S. PATENT DOCUMENTS

Examiner* Initials	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
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				Examiner Name	L.H. WHITMORE
Sheet	2	of	2	Attorney Docket Number	SPLX.P0089

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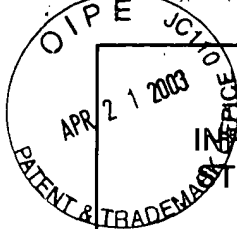
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PTO/SB/08A (08-00) - MODIFIED

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				Group Art Unit	2825
				Examiner Name	ETT WHITMORE
Sheet	3	of	3	Attorney Docket Number	SPLX.P0089

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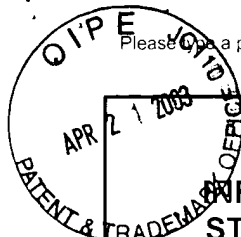
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		Office ³	Number ⁴	Kind Code (if known) ⁵				
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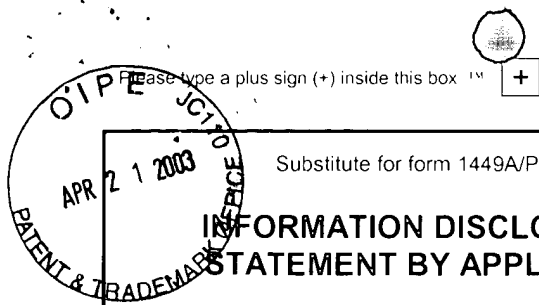
Examiner* Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
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